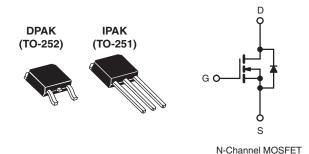


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	600				
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	4.4			
Q <sub>g</sub> (Max.) (nC)	18				
Q <sub>gs</sub> (nC)	3.0				
Q <sub>gd</sub> (nC)	8.9				
Configuration	Single				



#### **FEATURES**

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Surface Mount (IRFRC20/SiHFRC20)
- Straight Lead (IRFUC20/SiHFUC20)
- · Available in Tape and Reel
- · Fast Switching
- · Ease of Paralleling
- Lead (Pb)-free Available

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance cost-effectiveness.

The D PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFUC/SiHFUC series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surcace mount applications.

ORDERING INFORMATION							
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)		
IRFRC20PbF		IRFRC20TRLPbFa	IRFRC20TRPbFa	IRFRC20TRRPbFa	IRFUC20PbF		
Lead (Pb)-free	SiHFRC20-E3	SiHFRC20TL-E3a	SiHFRC20T-E3a	SiHFRC20TR-E3a	SiHFUC20-E3		
SnPb	IRFRC20	IRFRC20TRL <sup>a</sup>	IRFRC20TR <sup>a</sup>	IRFRC20TRR <sup>a</sup>	IRFUC20		
SIIFD	SiHFRC20	SiHFRC20TL <sup>a</sup>	SiHFRC20T <sup>a</sup>	SiHFRC20TR <sup>a</sup>	SiHFUC20		

#### Note

a. See device orientation.

<b>ABSOLUTE MAXIMUM RATINGS</b>	T <sub>C</sub> = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	600	V	
Gate-Source Voltage			$V_{GS}$	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	2.0		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	1.3	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	8.0		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount)e				0.020	VV/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	450	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	2.0	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	: 25 °C	$P_{D}$	42	w	
Maximum Power Dissipation (PCB Mount) <sup>e</sup>	T <sub>A</sub> =	T <sub>A</sub> = 25 °C		2.5	7 VV	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	-	260 <sup>d</sup>	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 206 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AS}$  = 2.0 A (see fig. 12).
- c. I<sub>SD</sub>  $\leq$  2.0 A, dI/dt  $\leq$  40 A/ $\mu$ s, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C. d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFRC20, IRFUC20, SiHFRC20, SiHFUC20

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	-	110	
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	-	50	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	-	3.0	

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.88	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zava Cata Valtana Duain Comunit	I <sub>DSS</sub>	V <sub>DS</sub> =	= 600 V, V <sub>GS</sub> = 0 V	-	-	100	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 480 V	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C			500	μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 1.2 A <sup>b</sup>	-	-	4.4	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 1.2 A		1.4	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0  MHz,  see fig. 5		-	350	-	pF
Output Capacitance	Coss			-	48	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	8.6	-	
Total Gate Charge	Qg			-	-	18	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 2.0 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	3.0	nC
Gate-Drain Charge	Q <sub>gd</sub>	1			-	8.9	
Turn-On Delay Time	t <sub>d(on)</sub>		1		10	-	- ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = 300 V, $I_{D}$ = 2.0 A, $R_{G}$ = 18 $\Omega$ , $R_{D}$ = 135 $\Omega$ , see fig. 10 <sup>b</sup>		-	23	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	30	-	
Fall Time	t <sub>f</sub>			-	25	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	""
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.0	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	8.0	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C}, \ I_S = 2.0  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 2.0 A, dI/dt = 100 A/μs <sup>b</sup>		-	290	580	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.67	1.3	μС
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	on is don	ninated by	y L <sub>S</sub> and I		

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

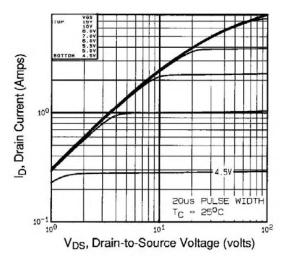


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

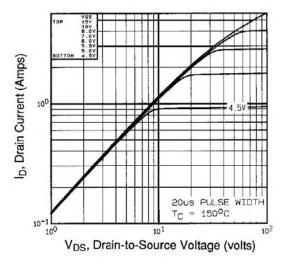


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

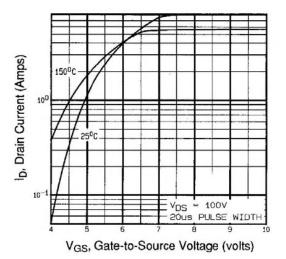


Fig. 3 - Typical Transfer Characteristics

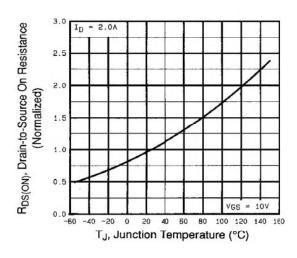


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFRC20, IRFUC20, SiHFRC20, SiHFUC20

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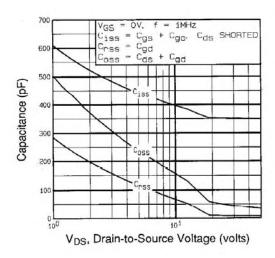


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

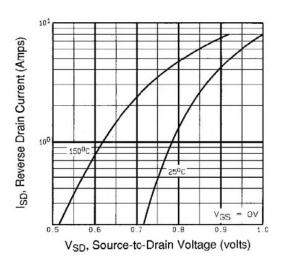


Fig. 7 - Typical Source-Drain Diode Forward Voltage

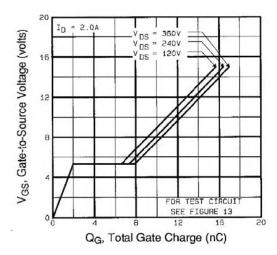


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

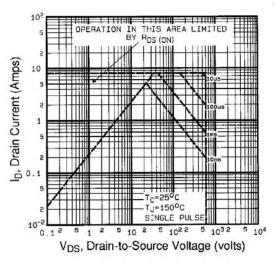


Fig. 8 - Maximum Safe Operating Area

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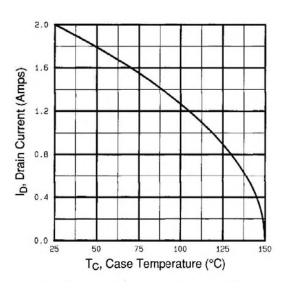


Fig. 9 - Maximum Drain Current vs. Case Temperature

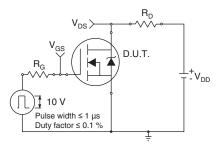


Fig. 10a - Switching Time Test Circuit

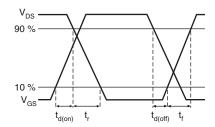


Fig. 10b - Switching Time Waveforms

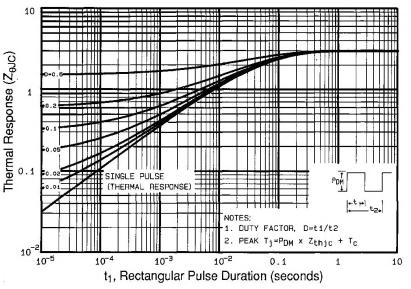


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFRC20, IRFUC20, SiHFRC20, SiHFUC20

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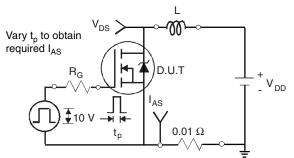


Fig. 12a - Unclamped Inductive Test Circuit

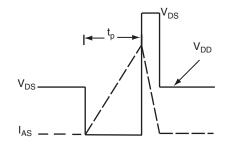


Fig. 12b - Unclamped Inductive Waveforms

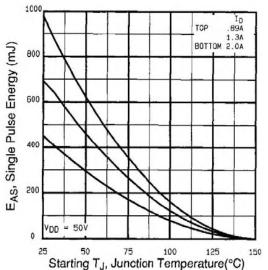


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

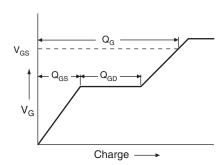


Fig. 13a - Basic Gate Charge Waveform

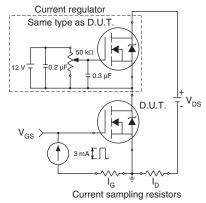
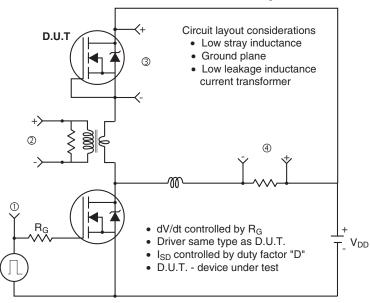
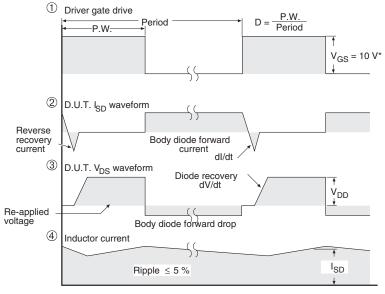


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com